

APPROVAL SHEET

MULTILAYER CERAMIC CAPACITORS

High Q / Low ESR Series (HH)

0201 to 0805 Sizes

NP0 Dielectric

Halogen Free & RoHS Compliance

*Contents in this sheet are subject to change without prior notice.



1. INTRODUCTION

MLCC consists of a conducting material and electrodes. To manufacture a chip-type SMT and achieve miniaturization, high density and high efficiency, ceramic condensers are used.

WTC HH series MLCC is used at high frequencies generally have a small temperature coefficient of capacitance, typical within the ±30ppm/°C required for NP0 (C0G) classification and have excellent conductivity internal electrode. Thus, WTC HH series MLCC will be with the feature of low ESR and high Q characteristics.

2. FEATURES

- a. High Q and low ESR performance at high frequency.
- b. Quality improvement of telephone calls for low power loss and better performance.

3. APPLICATIONS

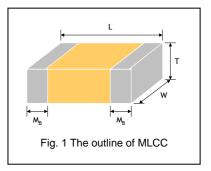
- a. Mobile telecommunication: Mobile phone, WLAN.
- b. RF module: Power amplifier, VCO.
- c. Tuners.

4. HOW TO ORDER

<u>HH</u>	<u>15</u>	<u>N</u>	<u>100</u>	<u>G</u>	<u>500</u>	<u>c</u>	I
<u>Series</u>	Size	Dielectric	<u>Capacitance</u>	<u>Tolerance</u>	Rated voltage	<u>Termination</u>	<u>Packaging</u>
HH=High Q/ Low ESR	03 =0201 (0603) 15 =0402 (1005) 18 =0603 (1608) 21 =0805 (2012)	N=NP0 (COG)	Two significant digits followed by no. of zeros. And R is in place of decimal point. eg.: R47=0.47pF 0R5=0.5pF 1R0=1.0pF 100=10x10 ⁰ =10pF	A=±0.05pF B=±0.1pF C=±0.25pF D=±0.5pF F=±1% G=±2% J=±5%	Two significant digits followed by no. of zeros. And R is in place of decimal point. 100=10 VDC 160=16 VDC 250=25 VDC 500=50 VDC 101=100 VDC 201=200 VDC 251=250 VDC 501=500 VDC 631=630 VDC	C =Cu/Ni/Sn	T=7" reeled G=13" reeled

5. EXTERNAL DIMENSIONS

Size Inch (mm)	L (mm)	W (mm)	T (mm)/Sym	bol	Remark	M _B (mm)
0201 (0603)	0.6±0.03	0.3±0.03	0.3±0.03	L	#	0.15±0.05
0402 (1005)	1.00±0.05	0.50±0.05	0.50±0.05		#	0.25 +0.05/-0.10
	1.60±0.10	0.80±0.10	0.80±0.07	s		
0603 (1608)	1.60 +0.15/-0.10	0.80 +0.15/-0.10	0.80 +0.15/-0.10	х		0.40±0.15
			0.60±0.10 A 0.80±0.10 B			
0805 (2012)	2.00±0.15	1.25±0.10				0.50±0.20
			1.25±0.10	D	#	



6. GENERAL ELECTRICAL DATA

Capacitance tolerance	Cap≤5pF**: A (±0.05pF), B (±0.1pF), C (±0.25pF) 5pF <cap<10pf: (±0.25pf),="" (±0.5pf)<="" c="" d="" th=""></cap<10pf:>			
•	Cap≥10pF: F (±1%), G (±2%), J (±5%): ANCE			
Rated voltage (WVDC)	10V, 16V, 25V, 50V, 100V, 200V, 250V, 500V, 630V			
Q*	Cap<30pF: Q≥400+20C Cap≥30pF: Q≥1000			
Insulation resistance at Ur	≥10GΩ or RxC≥100Ω-F whichever is smaller.			
Operating temperature	-55 to +125°C//			
Capacitance change	±30ppm			
Termination	Ni/Sn (lead-free termination)			

^{#1:} NP0, 0.1pF product only provide B tolerance

 $Apply \ 1.0 \pm 0.2 Vrms, \ 1.0 MHz \pm 10\% \ for \ Cap \leq 1000 pF \ and \ 1.0 \pm 0.2 Vrms, \ 1.0 kHz \pm 10\% \ for \ Cap > 1000 pF.$

7. PACKAGING DIMENSION AND QUANTITY

Size	Thickness (mm)/Cum	Pape	r tape	Plastic tape		
Size	Thickness (min)/Sym	Thickness (mm)/Symbol		13" reel	7" reel	13" reel
0201	0.30±0.03	L	15,000	70,000	-	-
0402	0.50±0.05	N	10,000	50,000	-	-
0000	0.80±0.07	S	4.000	45.000		
0603	0.80 +0.15/-0.10	Х	4,000	15,000	-	-
	0.60±0.10	Α	4.000	45.000		
0805	0.80±0.10	В	4,000	15,000	-	-
	1.25±0.10	D	-	-	3,000	10,000

Unit: pieces

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[#] Reflow soldering only is recommended.

^{*} Measured at the conditions of 25℃ ambient temper ature and 30~70% related humidity.

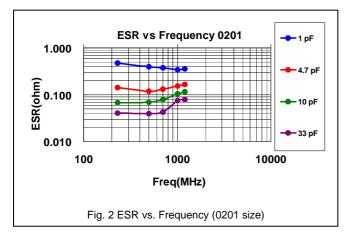
8. CAPACITANCE RANGE

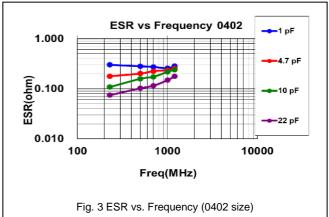
	DIELECTRIC										N	IP0									
	SIZE			0201				04	02			<u> v</u>	0603					08	05		
	Rated Voltage	10	16	25	50	100	16	25	50	100	16	25	50	100	200	50	100		250	500	630
	0.1pF (0R1)						N	N	N	N											
-	0.2pF (0R2)						N	N	N	N											
-	0.3pF (0R3)	L	L	L	L	L	N	N	N	N											
-	0.4pF (0R4)	L	L	L	L	L	N	N	N	N											
-	0.5pF (0R5)	L	L	L	L		N	N	N	N	S	S	S	S	S	В	В				
-	0.6pF (0R6)	L	L	L	L	L	N	N	N	N	S	S	S	S	S	В	В				
-	0.7pF (0R7)	L	L	L	L		N	N	N	N	S	S	S	S	S	В	В				
-	0.8pF (0R8)	L	L	L	L	 L	N	N	N	N	S	S	S	S	S	В	В				
-	0.9pF (0R9)	L	L	L	L	L	N	N	N	N	S	S	S	S	S	В	В				
-	1.0pF (1R0)	L	L	L	L	L	N	N	N	N	S	S	S	S	S	В	В	В	В	В	В
Ī	1.2pF (1R2)	L	L	L	L	L	N	N	N	N	S	S	S	S	S	В	В	В	В	В	В
-	1.5pF (1R5)	L	L	L	L		N	N	N	N	S	S	S	S	S	В	В	В	В	В	В
-	1.8pF (1R8)	L	L	L	L		N	N	N	N	S	S	S	S	S	В	В	В	В	В	В
-	2.2pF (2R2)	L	L	L	L	L	N	N	N	N	S	S	S	S	S	В	В	В	В	В	В
	2.7pF (2R7)	L	L	L	L	L	N	N	N	N	S	S	S	S	S	В	В	В	В	В	В
	3.3pF (3R3)	L	L	L	L	L	N	N	N	N	S	S	S	S	S	В	В	В	В	В	В
	3.9pF (3R9)	L	L	L	L	L	N	N	N	N	S	S	S	s	S	В	В	В	В	В	В
-	4.7pF (4R7)	L	L	L	L	L	N	N	ΣN.	N	S	S	S	S	S	В	В	В	В	В	В
	5.6pF (5R6)	L	L	L	L	L	N.	EN.	N	N	S	S	S	S	S	В	В	В	В	В	В
	6.8pF (6R8)	L	L	L	L	L	N	N	N	N	S	S	S	S	S	В	В	В	В	В	В
	8.2pF (8R2)	L	L	L	L		N	N	N	1N	S	S	IS	S	S	В	В	В	В	В	В
-	10pF (100)	L	L	L	Ī/	R	N'	N	N	N	S	S	/ S	S	S	В	В	В	В	В	В
-	12pF (120)	L	L	L	1/2	4/2	N	N	N	N	S	S	S	S	_	В	В	В	В	В	В
-	15pF (150)	L	L	L	L	L	N	N	N	N	S	S	S	s		В	В	В	В	В	В
မွ	18pF (180)	L	L	L	L		N	N	N	N	S	S	S	S		В	В	В	В	В	В
Capacitance	22pF (220)	L	L	L	L	L	N	N	N	N	S	S	S	S		В	В	В	В	В	В
Scit	27pF (270)	L	L	L	Ŀ	L	NÞ△	== M ve	aN =	=NA	-L:SAN	⊂∈S	S	S		В	В	В	В	В	В
ар	33pF (330)	L	L	L	E	1	N	N	N	N	S	S	S	S		В	В	В	В	В	В
0	39pF (390)			_	1	36	N	N	N	N	S	S	S	S		В	В	В	В	В	В
-	47pF (470)				13	5	N	N	N	N	S	S	S	S		В	В	В	В	В	В
-	56pF (560)					0	N	N	N	N	S	S	S	S		В	В	В	В	В	В
-	68pF (680)					1/2	N	N)	o N L	N	S	S	S	S		В	В	В	В	В	В
-	82pF (820)					1/4	/N/	γN	N	N	S	S	S	S		В	В	В	В	В	В
-	100pF (101)						N	//N/)	/\N/ ((NO	S	S	S	S		В	В	В	В	В	В
-	120pF (121)						N	N	N	UNIV	S	S	S	S		D	D	D	D	D	D
	150pF (151)				$\vdash \vdash$		N	N	N	N	S	S	S	S		D	D	D	D	D	D
	180pF (181)						N	N	N	N	S	S	S	S				D	D	D	D
	220pF (221)				$\vdash \vdash$		N	N	N	N	S	S	S	S				D	D	D	D
	270pF (271)				\vdash		N	N	N	_ · ·	S	S	S	S				D	D	D	D
	330pF (331)				\vdash		N	N	N		S	S	S	S				D	D	D	D
	390pF (391)						N	N	N		S	S	S	S				D	D	D	D
	470pF (471)						N	N	N		S	S	S	S				<u> </u>	<u> </u>	<u> </u>	<u> </u>
	560pF (561)							· ·			S	S	S	S							
	680pF (681)										S	S	S	S							
	820pF (821)										S	S	S	S							
	1,000pF (102)										S	S	S	S							
-	1,200pF (122)				Н						Х	X	X	Ť							
	1,500pF (152)										X	X	X								
	1,800pF (182)				$\vdash \vdash$						X	X	X								
	2,200pF (222)				$\vdash \vdash$						X	X	X								
	2,700pF (272)										X	X	X								
	3,300pF (332)				$\vdash \vdash$						X	X	X								
	3,300pF (332)										Х	X	X								

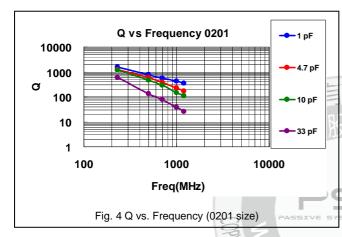
^{1.} The letter in cell is expressed the symbol of product thickness.

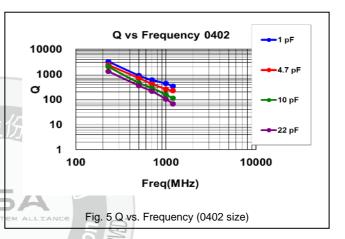
^{2.} For more information about products with special capacitance or other data, please contact WTC local representative.

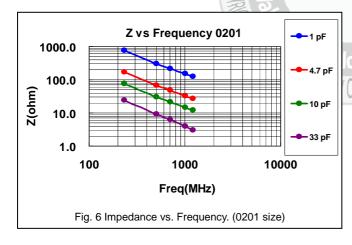
9. ELECTRICAL CHARACTERISTICS

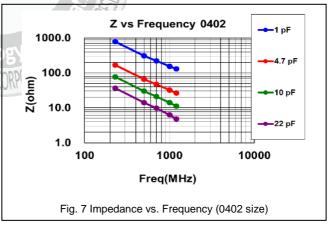


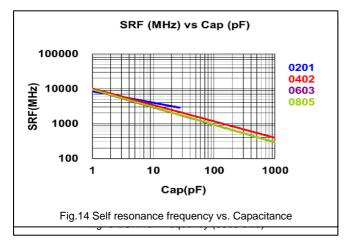


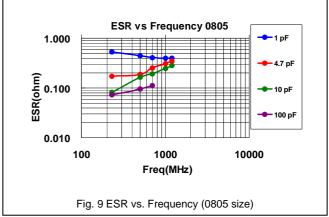


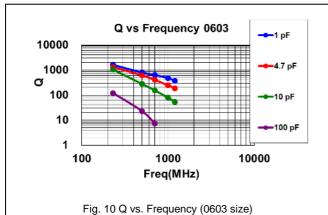


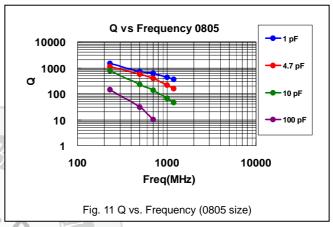


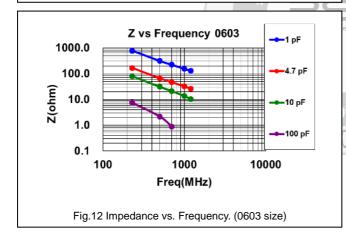


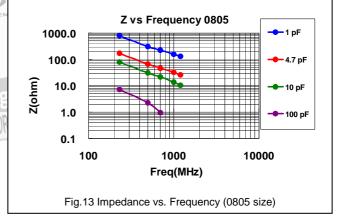














10. RELIABILITY TEST CONDITIONS AND REQUIREMENTS

No.	ltem	Test Conditions	Requirements
1.	Visual and		* No remarkable defect.
	Mechanical		* Dimensions to conform to individual specification sheet.
2.	Capacitance	* Test temp.: Room Temperature.	* Shall not exceed the limits given in the detailed spec.
3.	Q/ D.F.	Cap≤1000pF, 1.0±0.2Vrms, 1MHz±10%	* NP0: Cap≥30pF, Q≥1000; Cap<30pF, Q≥400+20C
	(Dissipation	Cap>1000pF, 1.0±0.2Vrms, 1KHz±10%	
	Factor)	At 25℃ ambient temperature.	
4.	Dielectric	* To apply voltage: (≤100V) 250% of rated voltage.	* No evidence of damage or flash over during test.
	Strength	* Duration: 1 to 5 sec.	
		* Charge and discharge current less than 50mA.	
		* To apply voltage:	
		200V~300V ≥2 times VDC	
		500V~999V ≥1.5 times VDC	
		* Cut-off, set at 10mA	
		* TEST= 15 sec.	
		* RAMP=0	
5.	Insulation	* Test temp.: Room Temperature.	≥10GΩ
	Resistance	Rated voltage:<200V	7
		To apply rated voltage for max. 120 sec.	2/11/2
			≥10GΩ or RxC≥100Ω-F whichever is smaller
		Rated voltage:200~630V	(L) \(\alpha\)
6.	T	To apply rated voltage (500V max.) for 60 sec.	* Constitutes also and within 200 pm/90
0.	Temperature Coefficient	With no electrical load. Operating temperature: -55~125℃ at 25℃	* Capacitance change: within ±30ppm/℃
7.			*No remarkable demonstrative of the terminations
٧٠	Adhesive Strength of	* Pressurizing force :	* No remarkable damage or removal of the terminations.
	Termination	2N (0201) and 5N (≤0603) and 10N (>0603) * Test time: 10±1 sec.	
8.	Vibration	* Vibration frequency: 10~55 Hz/min.	* No remarkable damage.
0.	Resistance	* Total amplitude: 1.5mm	* Cap change and Q/D.F.: To meet initial spec.
	Resistance	* Test time: 6 hrs. (Two hrs each in three mutually	Cap change and Q/D.F To meet initial spec.
		perpendicular directions.)	O. The
		* Cap./DF(Q) Measurement to be made after de-aging at	TOM. H.
		150℃ for 1hr then set for 24±2 hrs at room temp.	Alla
9.	Solderability	* Solder temperature: 235±5℃	95% min. coverage of all metalized area.
		* Dipping time: 2±0.5 sec.	
10.	Bending Test	* The middle part of substrate shall be pressurized by means	* No remarkable damage.
		of the pressurizing rod at a rate of about 1 mm per second until	* Cap change: within ±5.0% or ±0.5pF whichever is larger.
		the deflection becomes 1 mm and then the pressure shall be	(This capacitance change means the change of capacitance under
		maintained for 5±1 sec.	specified flexure of substrate from the capacitance measured before
		* Measurement to be made after keeping at room temp. for	the test.)
		24±2 hrs.	
11.	Resistance to	* Solder temperature: 260±5℃	* No remarkable damage.
	Soldering Heat	* Dipping time: 10±1 sec	* Cap change: within ±2.5% or ±0.25pF whichever is larger.
		* Preheating: 120 to 150℃ for 1 minute before imme rse the	* Q/D.F., I.R. and dielectric strength: To meet initial requirements.
		capacitor in a eutectic solder.	* 25% max. leaching on each edge.
		* Cap. / DF(Q) / I.R. Measurement to be made after de-aging	
		at 150℃ for 1hr then set for 24±2 hrs at room temp.	

^{* &}quot;Room condition" Temperature: 15 to 35°C, Relative humidity: 25 to 75%, Atmospheric pressure: 86 to 106kPa.



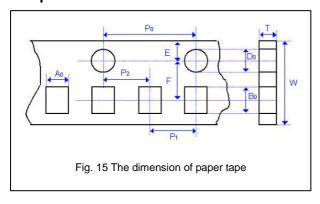
Multilayer Ceramic Capacitors

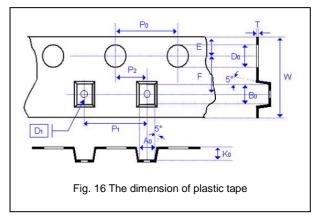
No.	Item		Test Condition	n		Requirements				
12.	Temperature	* Conduct the five cycles according to the temperatures and				* No remarkable damage.				
	Cycle	time.				* Cap change: within ±2.5% or ±0.25pF whichever is larger.				
		Step	Temp. (℃)	Time (min.)		* Q/D.F., I.R. and dielectric strength: To meet initial requirements.				
		1	Min. operating temp. +0/-3	30±3						
		2	Room temp.	2~3						
		3	Max. operating temp. +3/-0	30±3						
		4	Room temp.	2~3						
			PF(Q) / I.R. Measurement to be for 1hr then set for 24±2 hrs at		aging					
13	Humidity		np.: 40±2°C	room temp.		* No remarkable damage.				
13.			v: 90~95% RH			<u> </u>				
	(Damp Heat)		•			* Cap change: within ±5.0% or ±0.5pF whichever is larger. * Q/D.F. value:				
	Steady State		e: 500+24/-0hrs.							
		1 '	OF(Q) / I.R. Measurement to be		aging	NP0: Cap≥30pF, Q≥350; 10pF≤Cap<30pF, Q≥275+2.5C				
		at 150℃	for 1hr then set for 24±2 hrs at	room temp.		Cap<10pF; Q≥200+10C				
						* I.R.: ≥1GΩor RxC≥50Ω-F whichever is smaller.				
14.	Humidity	* Test ten	np.: 40±2℃			* No remarkable damage.				
	(Damp Heat)	* Humidit	y: 90~95%RH			* Cap change: within ±7.5% or ±0.75pF whichever is larger.				
	Load	* Test tim	e: 500+24/-0 hrs.			* Q/D.F. value:				
		* To apply	voltage: rated voltage (Max.	500V)		NP0: Cap≥30pF, Q≥200; Cap<30pF, Q≥100+10/3C				
		* Cap. / D	F(Q) / I.R. Measurement to be	made after de-	aging	* I.R.: ≥500MΩ or RxC≥25Ω-F whichever is smaller.				
		at 150℃	for 1hr then set for 24±2 hrs a	t room temp.	1					
15.	High	* Test ten	np.:	PILE	/	* No remarkable damage.				
	Temperature	NP0: 12	25±3℃	"	(分)	* Cap change: within ±3.0% or ±0.3pF whichever is larger.				
	Load	* To apply	voltage:	3 1 1 1 1 X		* Q/D.F. value:				
	(Endurance)	(1) <500\	(1) <500V: 200% of rated voltage.			NP0: Cap≥30pF, Q≥350				
		(2) 500V:	150% of rated voltage.	7		10pF≤Cap<30pF, Q≥275+2.5C				
		(3) ≥630\	/: 120% of rated voltage.			Cap<10pF, Q≥200+10C				
		* Test tim	e: 1000+24/-0 hrs.			* I.R.: ≥1GΩ or RxC≥50Ω-F whichever is smaller.				
		* Cap. / D	F(Q) / I.R. Measurement to be	made after de-	aging	IANCE 6				
		at 150℃	for 1hr then set for 24±2 hrs at	room temp.		6				

^{* &}quot;Room condition" Temperature: 15 to 35°C, Relative humidity: 25 to 75%, Atmospheric pressure: 86 to 106kPa.

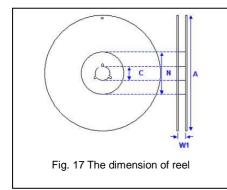
APPENDIXES

■ Tape & reel dimensions





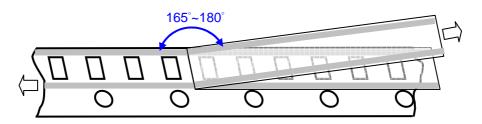
Size	0201	0402	0603		0805	
Thickness	L	N	S, X	Α	В	C, D, I
A ₀	0.40 +/-0.10	0.70 +/-0.20	1.05 +/-0.30	1.50 +/-0.20	1.50 +/-0.20	< 1.80
B ₀	0.70 +/-0.10	1.20 +/-0.20	1.80 +/-0.30	2.30 +/-0.20	2.30 +/-0.20	< 2.70
Т	≦0.55	≦0.80	≦1.20	≦1.15	≦1.20	0.23 +/-0.1
K ₀	-	· 清楚 PT	R	- 1	-	< 2.00
W	8.00 +/-0.30	8.00 +/-0.30	8.00	8.00 +/-0.30	8.00 +/-0.30	8.00 +/-0.30
P ₀	4.00 +/-0.10	4.00 +/-0.10	4.00 +/-0.10	4.00 +/-0.10	4.00 +/-0.10	4.00 +/-0.10
10xP ₀	40.00 +/-0.10	40.00 +/-0.10	40.00 +/-0.20	40.00 +/-0.20	40.00 +/-0.20	40.00 +/-0.20
P ₁	2.00 +/-0.05	2.00 +/-0.05	4.00 +/-0.10	4.00 +/-0.10	4.00 +/-0.10	4.00 +/-0.10
P ₂	2.00 +/-0.05	2.00 +/-0.05	2.00 +/-0.05	2.00 +/-0.05	2.00 +/-0.05	2.00 +/-0.05
D ₀	1.50 +0.1/-0	1.50 PASSIV +0.1/-0	€ SYST€1.50.LLIANCO +0.1/-0	1.50 +0.1/-0	1.50 +0.1/-0	1.50 +0.1/-0
D ₁	-	景台	-	28	-	1.00 +/-0.10
E	1.75 +/-0.10	1.75 +/-0.10	1.75 +/-0.10	1.75 +/-0.10	1.75 +/-0.10	1.75 +/-0.10
F	3.50 +/-0.05	3.50 +/-0.05	3.50 +/-0.05	3.50 +/-0.05	3.50 +/-0.05	3.50 +/-0.05



3/00 9	Indiani Co.	11/8/10	'			
Size	0201, 0402, 0603, 0805					
Reel size	NUCA UUSBUKKIN	10"	13"			
С	13.0±0.5	13.0±0.5	13.0±0.5			
W ₁	10.0±1.5	10.0±1.5	10.0±1.5			
Α	178.0±2.0	250.0±2.0	330.0±2.0			
N	60.0+1.0/-0	50 min	50 min			

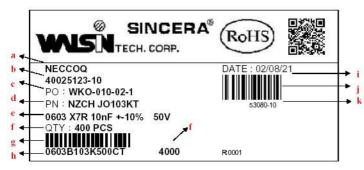
■ Peeling force (EIA-481)

Peel-off force should be in the range of 10 grams to 100 grams at a peel-off speed of 300±10 mm/min.



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■ Example of customer label

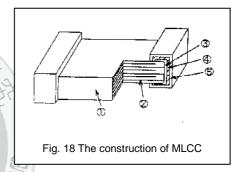


^{*}Customized label is available upon request

- a. Customer name
- b. WTC order series and item number
- c. Customer P/O
- d. Customer P/N
- e. Description of product
- f. Quantity
- g. Bar code including quantity & WTC P/N or customer
- h. WTC P/N
- i. Shipping date
- j. Order bar code including series and item numbers
- k. Serial number of label

Constructions

No.	Na	me	NP0
①	Ceramic	material	CaZrO₃ based
2	Inner el	ectrode	NI DA
3		Inner layer	Cu
4	Termination	Middle layer	脚 Ni U
(5)		Outer layer	Sn PASSIVE SYSTEM ALLIANCE



Storage and handling conditions

- (1) To store products at 5 to 40°C ambient temperature and 20 to 70%, related humidity conditions; MSL Level 1.
- (2) The product is recommended to be used within one year after shipment. Check solderability in case of shelf life extension is needed.

Cautions:

- a. The corrosive gas reacts on the terminal electrodes of capacitors, and results in the poor solderability. Do not store the capacitors in the ambience of corrosive gas (e.g., hydrogen sulfide, sulfur dioxide, chlorine, ammonia gas etc.)
- b. In corrosive atmosphere, solderability might be degraded, and silver migration might occur to cause low reliability.
- c. Due to the dewing by rapid humidity change, or the photochemical change of the terminal electrode by direct sunlight, the solderability and electrical performance may deteriorate. Do not store capacitors under direct sunlight or dewing condition. To store products on the shelf and avoid exposure to moisture.

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Recommended soldering conditions

The lead-free termination MLCCs are not only to be used on SMT against lead-free solder paste, but also suitable against lead-containing solder paste. If the optimized solder joint is requested, increasing soldering time, temperature and concentration of N_2 within oven are recommended.

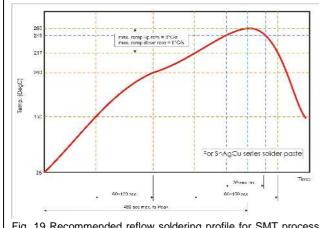


Fig. 19 Recommended reflow soldering profile for SMT process with SnAgCu series solder paste.

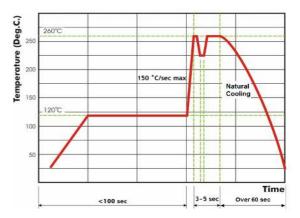


Fig. 20 Recommended wave soldering profile for SMT process with SnAgCu series solder.

